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	Application Number		10581940	
	Filing Date		2006-06-07	
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	Art Unit		2815	
(Not for Submission under 57 51 K 1.33)	Examiner Name Jeron		ome Jackson Jr.	
	Attorney Docket Number		30794.108-US-WO	

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	4	SCHNITZER et al., "30% external quantum efficiency from surface textured, thin-film light-emitting diodes," Appl. Phys. Lett. 63 (16), 18 October 1993, pp. 2174-2176.						
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	6	QI et al., "Study on the formation of dodecagonal pyramid on nitrogen polar GaN surface etched by hot H3PO4," Applied Physics Letters, 95, 2009, pp. 071114-1-071114-3.						
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